Single-shot m easurem ent of the Josephson charge qubit

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W e dem onstrate single-shot readout of quantum states of the Josephson charge qubit. The quantum bits are transformed into and stored as classical bits (charge quanta) in a dynamic mem ony cell-a superconducting island. The transform ation of state jli (di ering form state jli by an extra C ooper pair) is a result of a controllable quasiparticle tunneling to the island. The charge is then detected by a conventional single-electron transistor, electrostatically decoupled from the qubit. W e study relaxation dynamics in the system and obtain the readout e ciency of 87% and 93% for jli and jli states, respectively.

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It has been recently realized that Josephson junctions can be used for building quantum bits (qubits) and integrated quantum computer circuits controlled by external electrical signals [1, 2]. A fter the rst experiments on single Josephson qubits [3, 4, 5, 6, 7], an important step towards the integration has been made: coherent control of two qubits and conditional gate operation have been experim entally dem onstrated for two electrostatically coupled charge qubits [8, 9]. However, in these experiments, individual probabilities of each qubit averaged over all states of the other qubit were measured [10]. To directly m easure multi-qubit states, one must be able to readout each qubit after every single-shot coherent state m anipulation. The single-shot readout is of great in portance, for instance, for quantum state tom ography, quantum state teleportation, quantum cryptography [11]. W ithout the single-shot readout, algorithm s that give non-unique solutions can not be utilized.

To readout single quantum states of the Josephson qubits (in particular, ux qubits) through the phase degree of freedom, a few circuits, m easuring switching event from the supercurrent state to the nite-voltage state were implemented [4, 5, 6, 7]. In charge type of qubits, it is straightforward to measure a charge quantum instead of the ux quantum [12]. For the single-shot charge readout, a radio-frequency single-electron transistor [13] electrostatically coupled to the qubit was proposed as a detector of the charge states [14, 15]. A lthough this approach works in principle [16, 17], the single-shot readout has not yet been realized. In this work, we dem onstrate an operation and study mechanism of novel readout scheme that allows to perform highly e cient singleshot m easurem ents, with suppressed back-action of the m easurem ent circuit on the qubit.

A scanning-electron m icrograph of our circuit is shown in Fig. 1 (a) The device consists of a charge qubit [3] and a readout circuit. The qubit is a Cooper-pair box (with

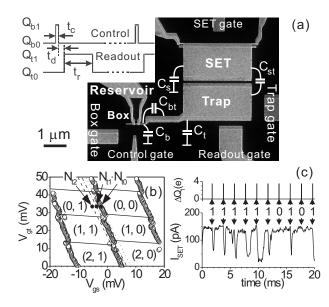
itse ective capacitance to the ground C_b 600 aF) coupled to a reservoir through a Josephson junction with the Josephson energy E_J 20 eV. The reservoir is a big island with about 0.1 nF capacitance to the ground plane and galvanically isolated from the external environm ent. The qubit states are coherently controlled by a non-adiabatic control pulse, yielding a superposed state of jDi and jLi. The readout part includes an electrom eter which is a conventional low -frequency single-electron transistor (SET) (C $_{\rm s}$ 1000 aF) and a charge trap (C_t 1000 aF) placed between the qubit and the SET. The trap is connected to the box through a highly resistive tunnel junction (R_t 100 M) and coupled to the SET with a capacitance C_{st} 100 aF. The use of the trap enables us to separate in time the coherent state manipulation and readout processes and, in addition, the qubit becom es electrostatically decoupled from the SET. The qubit relaxation rate induced by the SET voltage noise is suppressed by a factor of $(C_{bt}C_{st}=C_{t}C_{b})^{2}$ 3 10⁵, where C_{bt} 30 aF [18]. The coupling strength can be m ade even weaker, if the unwanted box-to-trap capacitance C_{bt} is further decreased.

The operation of the circuit can be described in the following way. During the qubit manipulation, the trap is kept unbiased prohibiting charge relaxation to the trap. Once the control pulse is term inated, the readout pulse (see the inset of Fig. 1 (a)) is applied to the trap. The length and the amplitude of the readout pulse are adjusted so that if there is an extra C ooper pair in the box after term ination of the control pulse, it escapes to the trap through a quasiparticle tunneling with a high probability. A fler the charge is trapped, it remains in the trap for a long time (a reverse trap-to-box charge relaxation is suppressed due to the superconducting energy gap 2) and is measured by a low-frequency SET.

The Ham iltonian of the two-level system of the qubit in the charge basis (0; and jli) (without and with an extra Cooperpair) is $H = U_b(0; Q_b)(jlih)j + U_b(2; Q_b)(jlih)j - 1/2 E_J ((jlih)j + jlih))$ (we de ne an electrostatic energy of island k as $U_k (N_k; Q_k) = (N_k e Q_k)^2 = 2C_k$, where k is either bort indicating box or trap island, respectively, N_k is an excess electron number, and Q_k is a gate in-

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(a) Scanning electron m icrograph of the device. FIG.1: The alum inum structure is deposited on top of a thin Si_3N_4 insulating layer (0.4 m) above a gold ground plane. The device consists of a Cooper pair box, a reservoir, a trap and a measurement SET. The dc ("box" and "trap") and pulse (control and readout) gates control potentials of the islands. Pulse operation is schem atically represented in the inset. (b) Stability diagram of the SET coupled to the trap. Open circlesmark positions of the SET quasiparticle current peaks on V_{qt} plane (dc gate voltages of the SET and the trap). Vgs Pairs of numbers (N $_{\rm t}$;N $_{\rm s}$) designate the trap - SET ground state charge con guration in each cell bounded by the SET peaks and solid lines. D ashed, dashed-dotted and dotted lines indicate positions of the SET peaks for 0, 1 or 2 additional electrons in the trap, respectively. (c) A typical time-trace of the SET current (lower panel) together with the readout pulse sequence (upper panel). Negative switches on the lower curve correspond to the detected charge of the trap. D igits 1 and 0 m ark readout bits.

duced charge in the island. Starting at Q_{b0} ($Q_{b0} < Q_{b1}$), where $E >> E_J$ ($E = U_b(2;Q_b)$) $U_b(0;Q_b)$) we let the system relax to the ground state, which is nearly pure charge state jDi. Then we instantly change the eigenbasis for a time t_c by applying a rectangular control pulse, which brings the system to Q_{b1} . If Q_{b1} is a degeneracy point (E = 0), the nal state of the control pulse m anipulation is jDicos! $_Jt_c=2 + jLisin! _Jt_c=2$ (! $_J = E_J=~$), therefore, after the pulse term ination, the state jLi is realized with a probability of \cos^2 ! $_Jt_c=2$.

Fig. 1 (b) shows an experimentally measured stability diagram : SET current peak positions as a function of trap and box gate voltages of the SET and the trap. By setting the box and trap gates to one of the points N_{t0}, N_{t1} or N_{t2}, we can detect if the trap has 0, 1 or 2 additional electrons. In our measurements, the SET is usually adjusted to N_{t0}. To readout the qubit, the trap is biased by the readout pulse of typical length $t_r = 300$ ns and am plitude $Q_t = 3.5e$ ($Q_t = Q_{t1} - Q_{t0}$), applied to the readout gate, letting an extra C ooper pair of the state

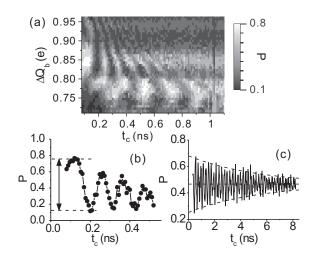


FIG. 2: (a) C oherent oscillations m easured by averaging over m any events of the single-shot m easurem ents. (b) P versus t_c m easured at Q $_{\rm b}$ = 0.84e ($Q_{\rm bA}$), where visibility is the highest. (c) P versus t_c m easured at Q $_{\rm b}$ = 0.75e ($Q_{\rm bB}$), where the oscillations are the longest lasting (degeneracy point). D ashed envelops correspond to the exponential decay with the decay time of 5.8 ns.

jli escape to the trap through a quasiparticle tunneling and switching o the SET current (the SET peak position is shifted to the position of the dashed line).

The curve in the upper panel of Fig. 1 (c) indicates a readout pulse sequence. The curve on the lower panel dem onstrates a typical time-trace of the SET current. Negative switches on the curve of the lower panel com - ing synchronously with the readout pulses are counted as charge detection events. For the studied device, the lifetime of the trapped charge is typically about 300 s, therefore, normally used repetition time of 2 m s is suf-

cient for practically com plete trap resetting. W e count the num ber of detected sw itches m , w ith the total num – ber of shots $n_{\rm t}.$

An experim entally obtained probability of the charge detection $P = m = n_t$ (norm ally, $n_t = 327$ is used per one experimental data point) as a function of the control pulse length $t_{\rm c}$ and the amplitude $~{\tt Q}_{\rm b}$ (${\tt Q}_{\rm t}$ = Q_{t1} Q_{t0}) is shown as a two-dimensional plot in Fig. 2 (a). We de ne the pulse with $Q_{\rm b} = 0.84e$ ($Q_{\rm bA}$) and $t_c = 120 \text{ ps}$, when P reaches maximum, as a -pulse. Fig. 2(b) dem onstrates coherent oscillations as a function of t_c m easured at Q_{bA} . As shown by the vertical arrowed line, the visibility here reaches 0.64, while the longest lasting oscillations shown in Fig. 2 (c) are found at $Q_b = 0.75e$ (Q_{bB}), (the phase decoherence is expected to be the weakest at the degeneracy point). We believe that $Q_{bA} \notin Q_{bB}$ due to the control pulse distortion because of limited frequency bandwidths of the transm ission lines and the pulse generator.

Curves with open and closed dots in Figs. 3(a-b) represent P as a function of the readout pulse amplitude Q_t with and without control -pulses, respectively. The

FIG. 3: P versus readout pulse amplitude Q t with and without -pulse (open and closed cycles, respectively). (a) P m easured at N to (see Fig. 1 (b)). (b) P m easured at N t₂. O nem ay distinguish three di erent regions on the plots: (I) a nite probability for the excited state detection is only at N t₀ position; (II) nite probabilities for the excited state detected tion are at N t₀ and N t₂ positions; (III) switches are detected even if the qubit is in the state [Di. Threshold am plitudes Q t_A, Q t_B, Q t_C are derived for the box-to-trap relaxation processes (2;0) ! (1;1), (1;1) ! (0;2) and (0;0) ! (1;1), respectively.

probabilities measured at N_{t0} are shown in Fig. 3(a), while the probabilities measured at N_{t2} (where positive switches are counted) are shown in Fig. 3(b). One may divide the plots into three regions marked by I, II and III di ering from each other by the counting characteristics. Based on the data from these plots, we suppose that when the qubit is in the state jli, one quasiparticle tunnels from the box to the trap in the process (2, 0) ! (1, 1) within the region I ((N_b; N_t) represents the boxtrap quasiparticle con guration); quasiparticles tunnel to the trap in the process (2, 0) ! (1, 1) ! (0, 2) within the region II; a quasiparticle tunneling process becomes possible even for the state jDi in the region III.

The quasiparticle tunneling is energetically feasible in the process $(N_b; N_t) ! (N_b)$ $1; N_t + 1), when the fol$ lowing condition is satis ed $U_b(N_b;Q_{b0}) + U_t(N_t;Q_{t1}) >$ U_b(N_b $1;Q_{b0}) + U_t (N_t + 1;Q_{t1}) + 2$ [19] (we neglect the interaction energy term which is as small as the interisland coupling strength). Substituting an explicit expression for the energies, one may nd the necessary trap readout pulse amplitude for the quasiparticle escape $Q_t > Q_t^0 + N_t e^+$ (2 N_b)e, where = $C_t = C_b$ and $Q_{+}^{0} = e=2$ $(3e=2 Q_0)+2 C_t=e Q_{t0}.Wede nethree$ threshold am plitudes of Q_{t} , at which the following processes become possible: (2, 0) ! (1, 1) at $Q_t > Q_{tA}$, where $Q_{tA} = Q_{t}^{0}$; (1, 1) ! (0, 2) at $Q_{t} > Q_{tB}$, where $Q_{tB} = Q_t^0 + (1 +)e; (0, 0) ! (-1, 1) at Q_t > Q_{tC}$, where $Q_{tC} = Q_t^0 + 2$ e. The threshold am plitudes calculated with $Q_{tA} = 0$:6e (taken from the step of P curve on Fig. 3(a)) and = 1.67 are $Q_{tB} = 3.3e$ and $Q_{tC} = 3.9e$ and shown on the Figs. 3 (a-b) by the dashed vertical lines. Note that the probability for the trap to have a charge at $Q_t > 4$:5e reaches 1 in Fig. 3(a). This proves that once the charge is trapped it is detected with 100% probability. For the highest e ciency, we set the operation point of the SET to N_{t0} , where either one or two trapped quasiparticles yield a negative switch of the

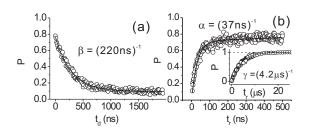


FIG.4: (a) P as a function of delay between the control – pulse and the readout pulse t_d . A solid curve is a tring by an exponent with a decay rate = (220 ns)¹. (b) A probability of jli-states detection created by the -pulse as a function of the readout pulse length t_r . A solid curve is a result of tring m (t) using Eq. (1) norm alized by n_t with tring parameters n_0 and $(n_0=n_t=0.87 \text{ and } = (37 \text{ ns})^{-1})$. The inset shows probability without -pulses. P is tted by $1 - \exp(-t_r)$ with = (4.1 s)¹.

SET current and the pulse am plitude to Q_t 3.5e, at which two quasiparticles may escape to the trap.

Figs. 4 (a-b) dem onstrate tim e relaxation dynam ics of the qubit states. Fig. 4 (a) shows a probability P to nd an extra charge in the trap, when time delay t_d is introduced between the control -pulse and the readout pulses. The exponential decay of P m ay be explained by tunneling to the reservoir (presum ably via energetically feasible Cooper pair tunneling (2, 0) ! (0, 0) because alternative quasiparticle relaxation to the trap through the high resistive junction is blocked by 2 when the trap is not biased. The relaxation rate to the reservoir found from the tting (solid curve) is = $(220 \text{ ns})^1$. Fig. 4(b) shows relaxation dynamics of the state ili as a function of the readout pulse length t_r (t_d 0). This relaxation is mainly determined by quasiparticle decay to the trap with a rate (). Additionally, the inset of Fig. 4 (b) shows dynam ics of Di-state relaxation ("dark" switches) to the trap. These "dark" switches can be presumably described by the process (0, 0) ! (-2, 2), with a weak relaxation rate = $(4100 \text{ ns})^{-1}$ derived from tting the data by $1 - \exp(\frac{1}{r})$ (solid curve).

Let us consider the relaxation dynam ics in more details. The number of excited states, n, decreases within the time interval [t;t + dt] as dn (t) = n (t)dt n (t)dt [20]. The number of states in (0, 0) con guration, n (t), changes, in turn, as dn (t) = n (t)dt + n (t)dt. W e m ay also write an expression for the num ber of events in which the trap is found to be charged: dm (t) = n (t)dt + n (t)dt. Solving these equations with

$$m(t) = n_t [1 e^t] + \frac{n_0()}{+} [e^t e^{(+)t}]: (1)$$

n_b and

the initial conditions $n(0) = n_0, n(0) = n_t$

m(0) = 0 we nd

We t the data of Fig. 4 (b) by a curve of P = m (t)= $n_{\rm t}$ with m (t) taken from Eq. (1) with two tting parameters and n_0 . The tting gives = (37 ns)¹ [21] and $n_0=n_{\rm t}$ = 0.84, in plying that the e ciency of jDi-to-jLi

conversion by the control -pulse is 84%.

If our readout pulse length $t = t_r$ satis es the conditions $t_r^1 +$, then Eq. (1) can be simplified to

m (t)
$$n_0 - + t_r [n_t - n_0 - +]$$
: (2)

U sing Eq. (2), one may estimate an e-ciency of the single-shot readout. We introduce a probability $P_y(x)$ of nding the trap charged (y = 1) or uncharged (y = 0), when the qubit is in jxi-state (x is either 0 or 1). A coording to the de nition of $P_y(x)$, $P_0(0) + P_1(0) = 1$ and $P_0(1) + P_1(1) = 1$. The total number of detected events expressed in terms of these probabilities may be written as $m = n_0P_1(1) + (n_t - n_0)P_1(0)$. Comparing the latter expression with Eq. (2) we nd

$$P_1(1) = \frac{+ t_r}{+}$$
 (3a)

$$P_1(0) = t_r$$
: (3b)

C on m ing that our readout pulse length $\ddagger = 300$ ns fulls the necessary condition for Eqs. (3), \ddagger^1

+ , we directly nd from Eqs. (3) that the probability of detection of the state jli is $P_1(1) = 0.87$ and the state jli is $P_0(0) = 0.93$ ($P_1(0) = 0.07$). The readout effective of the state sta

ciency can be further in proved by optim izing the relaxation rates. The derived probabilities are consistent with the mean probability of the oscillations at the degeneracy point, $hP i = [m_0 iP_1 (1) + (n_t \quad m_0 i)P_1 (0)] = n_t = 0.47$ (horizontal line in Fig. 4 (c)), where $hn_0 = n_t i = 0.5$.

Finally, we would like to brie y discuss new possibilities and potential applications, which this scheme opens. The trap island works as a dynam ic memory cell, which stores the multi-qubit state in a classical bit. Therefore, the data can be further processed in a classical way. For example, im plementing sequential readout of many cells connected in series, similarly to that of charge-coupled devices will allow to reduce a number of output circuit channels.

One of straightforward applications of the described device, staying outside quantum computation direction, is a tunable single-photon detector in a centim eterwavelength range. A weak microwave radiation may resonantly excite the box near the degeneracy point from the ground to the excited state with a nite probability. The excited state may then be converted into the charge state jliby an adiabatic sweep of the control gate voltages (a relatively slow gate voltage change forces the system to move along eigenenergy bands) and detected by the single-shot measurement circuit.

As for the nearest plans, it is straightforw and to use the single-shot readout to form easuring double qubit system [8, 9]. This will allow us to demonstrate entangled states and controlled-NOT gate operation.

W e thank S.Lloyd for valuable discussion.

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- [19] In our case of the high resistive junction and relatively short readout pulses, an additional energy 2 is needed for quasiparticle tunneling independently of parity because of low tunneling rate of an unpaired quasiparticle.
- [20] We simplify this problem avoiding consideration of the detailed relaxation mechanism and assume that n includes any (N_b, 0) charge con gurations with N_b \in 0. Most importantly, the experimentally measured decay of n in Fig. 4(a) is perfectly exponential.
- [21] The tunnel junction resistance is estimated as R $_{\rm t}$ 2 = e 2 = 100 M .